

Clean Unit System Platform (CUSP) for various frontier experiments and applications

A. Ishibashi, M. Yasutake, N. Noguchi, T. Etoh, J. Matsuda, K. Nakaya, T. Osawa, Y. Sato, N. Ohata, Md. D. Rahaman, J. Alda, Y. Ohashi

Abstract— A clean unit system platform (CUSP), i.e., a system having fan-filter-unit with 100% feedback, is shown to be versatile. Desk-top type CUSPs, Mobile CUSP, room-type CUSP in which people can stay doing processes, and tent-type CUSP are now available. Cleanliness of US 209D class 1 (ISO class 3) can be realized in an inexpensive compact manner with CUSP, no matter how dusty its ambient is. In terms of small footprint, low power-consumption and high cost-performance, CUSP in its full line-up could outperform a conventional super cleanroom, i.e., the “main frame,” and will be the *clean space for all of us*.

Index Terms—Clean room, clean space, particle count, CUSP.

I. INTRODUCTION

In near future, clean environment [1],[2] would surely be necessary to perform cross-disciplinary experiments, especially uniting or unifying bottom-up systems with top-down systems [3]-[5] through the fusion of cutting-edge research technologies such as semiconductor-based nanotechnologies and bio-technologies in addition to flexible assembly processes.

A clean versatile environment having small footprint, low power-consumption and high cost-performance has been needed for the next generation production system as well as for cross-disciplinary experiments. In this context, physics of enabling highly clean environment in less expensive, compact manner is getting of much importance, for many of

Akira Ishibashi is at Laboratory of Nanostructure Physics, Research Institute for Electronic Science, Hokkaido University, N20W10, Sapporo, Hokkaido 001-0020, Japan.

M. Yasutake is at Department of General Medicine & Health Science, Nippon Medical School, Tokyo 113-0022, Japan.

N. Noguchi is at Ishibashi Architects and Associates, 1-7-21 Hyougo-kita, Saga-city, Saga 849-0919, Japan.

T. Etoh is at Kindai Setsubi-Sekkei Jimusho, 558-15 Mitsusemura-yuzuriha, Saga-city, Saga 842-0303, Japan.

J. Matsuda is at Hiei Kensetsu, 3-16-2 Hiragishi, Sapporo, Hokkaido 062-0933, Japan.

K. Nakaya is at Dental VAMOS, Sapporo, Japan.

T. Osawa is at Hokkaido Univ. Hospital, N14W5, Sapporo, Hokkaido 060-8648, Japan.

Y. Sato and **N. Ohata** are at Graduate School of Dental Medicine, Hokkaido Univ., N13W7, Sapporo, Hokkaido 060-8586, Japan.

Md. D. Rahaman is at Dept. Phys., Dhaka Univ., Bangladesh.

J. Alda is at Optics Department, University Complutense of Madrid, Av. Arcos de Jal'on s/n. 28037 Madrid, Spain.

Y. Ohashi is at C'sTEC Corp., N8W6, Sapporo, Hokkaido 060-0808 Japan.

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tools and processes to be used have already been established in being compact.

Clean unit system platform (CUSP) having fan-filter unit (FFU) operate in 100% feedback configuration or closed loop design in an air-tight space, can take a form not only of compact multiply connected clean boxes but also as a hand-carry clean box, desk-top compact box, tent-type clean space, a room, or even a full building. CUSP serves as a clean versatile environment having low power-consumption and high cost-performance, and is suitable not only for processing the next generation new devices [6],[7], but also for cross-disciplinary fields, including medical/hygienic applications. Processes and analyses can be performed in CUSP as extensively as in high performance cleanrooms, much in an inexpensive manner, just like well-designed connected workstations and/or PCs can sometimes outperform expensive mainframe computers.

II. EXPERIMENTAL RESULTS AND DISCUSSION

Figure 1(a) shows how a conventional clean room or a clean booth works. In the conventional system, fan-filter-unit (FFU) on the ceiling inhales the ambient air, filtrates it, and pushes it into the main chamber of the cleanroom, where the filtrated clean air dilutes the dusty air inside. Thus the air inside becomes cleaner than that outside. The air inside, which, being subject to activities done by users, gets some dusts out of them, then goes out of the chamber/room, and the cleanliness is maintained in the cleanroom. Thus, the conventional cleanroom is open system in that ambient air comes in and inside air goes out to merge with the ambient air eventually. We note that in the conventional cleanrooms the cleanliness is achieved only indirectly or *passively* by diluting the dusty inside air by filtrated clean air (as shown in Fig. 1(a), the FFU, just filtrating the ambient air, never collects the particles in the chamber). The particles, dusts and/or microbes, go outside, being contained in the outgoing air (thus, depending on what are contained, there could be a risk that people who inhale the air may suffer from them). Further, the conventional cleanroom's FFU, put at the

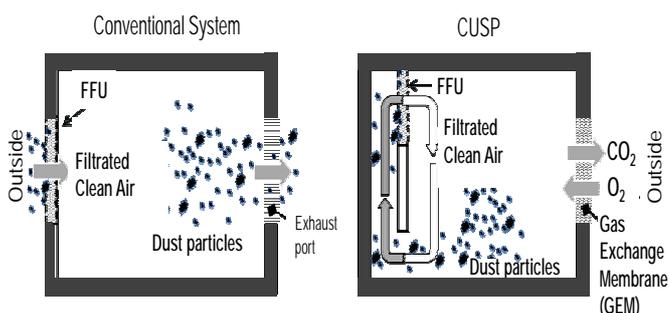


Fig. 1 (a) Conventional system (left) and (b) CUSP (right).

interface between the ambient and cleanroom, keeps on clogging filtrating the ambient air, which, of course, is infinite in its volume, until it loses its filtrating ability because of the eventual heavy clogging.

On the other hand, in CUSP, as shown in Fig. 1(b), all of the air coming in (to the main chamber) from the outlet of the FFU go back to the inlet of the FFU, i.e., 100% feed-back is done. Thus, the key point of the CUSP is the closed loop, or close circuit design. The CUSP's FFU inhales the return air coming through its inlet, filtrates it and then push it back into the main chamber of the CUSP. Note that in this system the FFU is detached from the ambient air, and so is the main chamber of the CUSP. Thus, the CUSP is closed (isolated) system in that there is no net air-flow exchanged between inside and outside of the CUSP. The ambient air *never* goes into CUSP as a net air-flow. In CUSP, the cleanliness is achieved directly or *actively* by collecting particles (dusts and/or microbes) inside. We call the FFU in CUSP as *active* filter system [8]. The particles generated in the chamber/room in this system never go outside (therefore, there is least risk that people outside might suffer from those particles, even if those particles are toxic or made of harmful microbes). The CUSP's FFU, detached from the ambient air, stops clogging in a finite (actually very short) time of period when cleanliness is achieved, with the inner air having run through the FFU roughly 10 times (thus, in a couple of minutes or tens of minutes, depending on the flow rate F of the FFU and the volume V of the chamber). In a CUSP for people to work or stay inside, a part of the wall is made of a gas-exchange membrane (GEM), through which gas molecules diffuse if there exists concentration gradient across the membrane. Thus, if oxygen concentration becomes low due to O_2 consumption inside CUSP, the oxygen is fed in through GEM from outside.

Let us consider how the conventional system shown in Fig. 1(a) works. The particle (dust) density $n(t)$ in the chamber, i.e. clean room or clean box, changes governed by the equation,

$$V \frac{dn(t)}{dt} = S\sigma - n(t)F + N_o F(1-\gamma) \quad (1)$$

where V and S , σ , and N_o are, respectively, the volume of the chamber, area of the inner surface of the chamber, rate of particles coming from the unit area per unit time, and the particle density of the environment where the conventional clean room itself is placed. F is the flow rate of the HEPA/ULPA fan filter unit, and γ is the filtrating efficiency of the FFU. Equation (1) can be solved exactly quite easily [4] but what we are interested in is the steady-state particle count, n , being obtained just by putting LHS of Eq. (1) i.e., $dn/dt = 0$, and it is given by

$$n = \frac{S\sigma}{F} + (1-\gamma)N_o, \quad (2)$$

which tells us that $n(t)$ is dependent on the ambient dust density N_o forever, and that high performance filter with γ very close to one is indispensable in the conventional clean room.

In the case of Fig. 1(b), however, we have the equation:

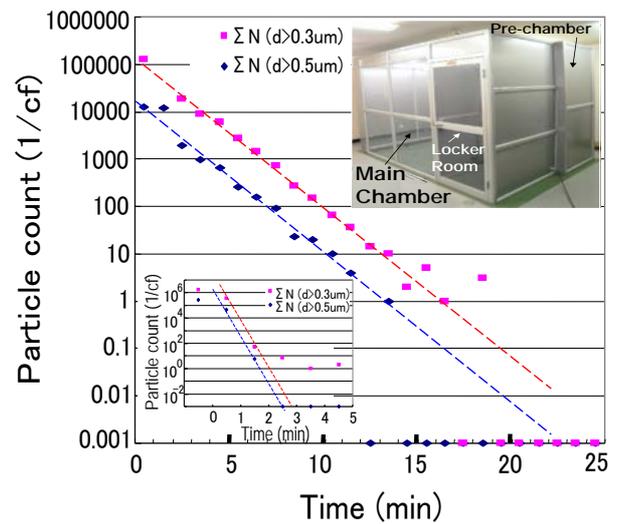


Fig. 2 Particle count as function of time in main chamber of L-CUSP. Upper inset shows the picture of L-CUSP and the bottom left inset shows the time-dependence of the particle count in the pre-chamber of the

$$V \frac{dn(t)}{dt} = S\sigma - n(t)F + n(t)F(1-\gamma) \quad (3)$$

$$= S\sigma - \gamma Fn(t).$$

The solution is:

$$n(t) = \frac{S\sigma}{\gamma F} + [N_o - \frac{S\sigma}{\gamma F}] e^{-\frac{\gamma F}{V} t}, \quad (4)$$

which is obtained with the boundary condition $n(0) = N_o$. Again we are interested in the steady-state particle count, which is given by

$$n = \frac{S\sigma}{\gamma F}. \quad (5)$$

This is the steady state dust density obtained as time goes by in CUSP. As seen in Eq. 4, the cleanliness in CUSP chamber is indeed dependent on the ambient dust density at $t \sim 0$, but soon at a time when $t/(V/F) \sim 10$ or later, the cleanliness in the

CUSP chamber becomes independent of the ambient dust density N_o , and is given by Eq. 5. As Eqs. 2 and 5 teach us, in conventional system, γ being as close to unity as possible ($\gamma=0.997$ for HEPA, or $\gamma=0.99997$ for ULPA) is important but in CUSP γ close to 1 is not so much indispensable ($\gamma \sim 0.95$ can give class 10~100 as we see below).

Figure 2 shows the time dependence of the airborne particle count in the Lung-CUSP (L-CUSP), i.e., a CUSP that

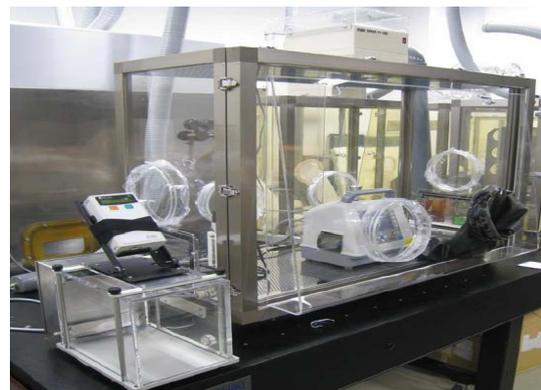


Fig. 3 Mobile CUSP (left) and a desk top CUSP (right).

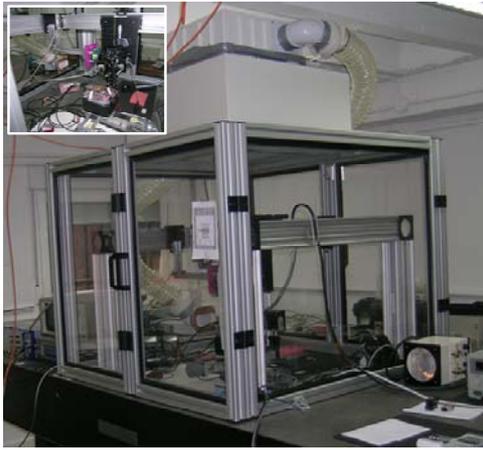


Fig. 4 Desk-top CUSP for optical experiments. The inset shows the nanophotonic experimental setup.

has GEM as shown in Fig. 1, and people stay long inside by exploiting its lung-like feature. The top inset of Fig. 2 is a picture of the L-CUSP whose size is roughly 3m long, 2m wide, and 2.3m high. The solid square shows the number, per cubic feet, of particles whose size is $0.3\mu\text{m}$ or larger and the solid diamond that $0.5\mu\text{m}$ or larger. Measured zero counts are plotted at $n=0.001$ for simplicity to avoid infinity. As seen from Fig. 2, the cleanliness inside becomes as good as US FED 209D class 1 (= ISO class 3) in about 20 minutes. The L-CUSP is equipped with a pre-chamber that also has the CUSP 100% feed-back system which also serves as air shower. The cleanliness in the pre-chamber reaches at US 209D class 1 quickly in two minutes. Thanks to the pre-chamber, we can go into the main chamber without breaking the high cleanliness of it.

As seen from Eqs. 4 and 5, CUSP is scalable and we can make hand-carry CUSP (left-hand side) or mobile CUSP (M-CUSP) and a desk-top CUSP (right-hand side) as shown in Fig. 3, both of which enables high cleanliness [9]-[13]. M-CUSP, with a size is $23\text{ cm} \times 30\text{ cm} \times 35\text{ cm}$, working 10 hours with four AA batteries connects any two clean facilities. Desktop CUSP can be used not only as clean version of a glove box, but also for optical and nanophotonic experimental platforms. Figure 4 shows the system that maintains a total volume of about 1 m^3 used for the characterization of nanophotonic devices. In this application, dust can affect the amount of light directed towards the workplane due to scattering on the mirrors and optical

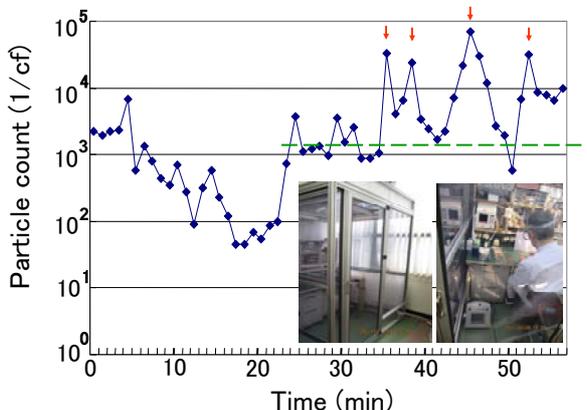


Fig. 5 Particle counts under the dental processes in DSS. The left inset shows the outlook of DSS, and the right one the dental work being performed inside.

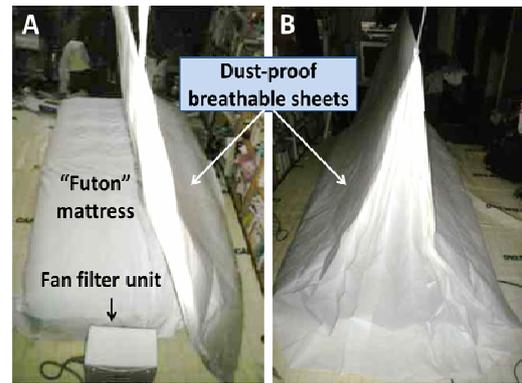


Fig. 6 A tent-type CUSP (T-CUSP): a) when out of use, and b) when in use.

surfaces. Besides, when working with high power laser, dust may burn and degrade optical surfaces. Nanophotonic elements exposed to the ambient air can be damaged with dust particles that are deposited and fixed electrostatically at those locations where electric fields are enhanced. Then, CUSP reduces the maintenance stops of the experimental equipment and preserves samples and devices longer.

The CUSP system with GEM can be used for a dental technician to perform dental work as shown in the right inset of Fig. 5. We call this set-up a dental safety system (DSS), whose outlook is shown in the left inset of Fig. 5. We have investigated how particle count changes when various dental technological processes are done in DSS. Figure 5 shows the particle counts: first, for a couple of tens of minutes, metal polishing is performed, but as shown in Fig. 5, the particle count goes down and the cleanliness is as good as class 100 (ISO class 5) even when the metal polishing is done inside. Then, after 20 minutes, process is switched to polishing with abrasives, and red arrows in Fig. 5 denotes the timing when a blower is used, for which the particle count increases, but the cleanliness is class 10000~100000 (ISO class 7~9), a typical cleanliness for offices, which demonstrates very high performance of DSS to keep the dust count moderate even if there is much dust generation inside. DSS will serve as a good platform for dental processes making it possible to protect dental technicians from heavy dust generations.

Japan has a long tradition of “Kaya” a net to prevent mosquitos from getting close while people are sleeping especially for summer. We have expanded the concept of Kaya by replacing the target, i.e., mosquitos by particles/dusts, and developed the tent type CUSP (T-CUSP) as shown in Fig. 6. People can sleep inside T-CUSP as usual with futon or mattress as shown in the left picture of Fig. 6.

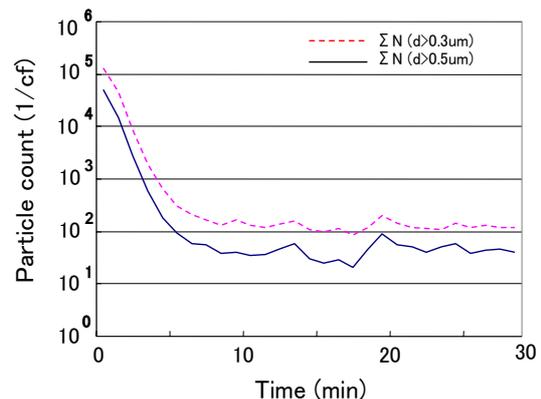


Fig. 7 Time-dependence of particles count in T-CUSP.

The T-CUSP size is compact, i.e., just enough to cover futon/mattress, which makes the volume of T-CUSP small and, as predicted from Eq. 4, low particle state is established quickly. The flow rate of FFU used in T-CUSP is about 1 cubic meter per minute. The cleanliness provided is shown in Fig. 7. The solid line shows the number per cubic feet of particles whose size is 0.5 μm or larger. The cleanliness reaches class 100 in 5 minutes. Note that super cleanrooms have been used almost exclusively for semiconductor device processing, and it would be ridiculous to even try to sleep in super cleanroom with ordinary bedclothes. With T-CUSP, however, it has become quite affordable to sleep in clean-space. Users can enjoy non-invasive, non-contact natural sleeping [14] in clean air, being free from nuisance of using a mask, under lower risk of suffering from PM2.5 [15],[16] and/or diseases mediated by airborne microbes.

CUSP system could even scaled up to various size of rooms as shown in Fig. 8 and 9. The room shown in Fig. 8 is about 70 m^3 , and that in Fig. 9 is with a volume of 800 m^3 . CUSP FFU flow rate is 16.7 m^3/min for the medium-sized room and the cleanliness achieved is roughly class 1000 (ISO class 6). For the large-sized room, the flow rate of CUSP FFU is 70 m^3/min and the cleanliness achieved is about class 5000. Those results are in good accord with the scaling property predicted by Eqs. 4 and 5.

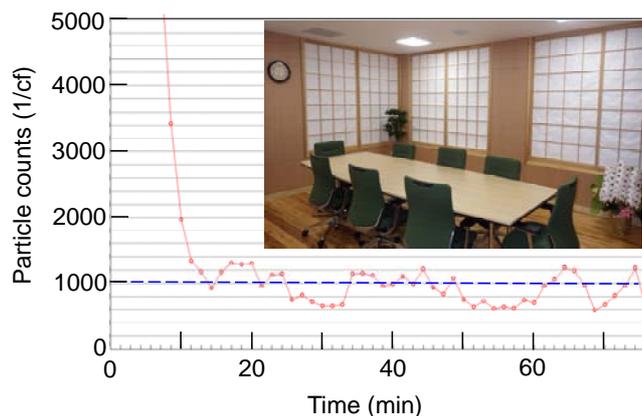


Fig. 8 Particle count as function of time in a medium-sized room-type CUSP. The inset is a picture of the room having GEMs.

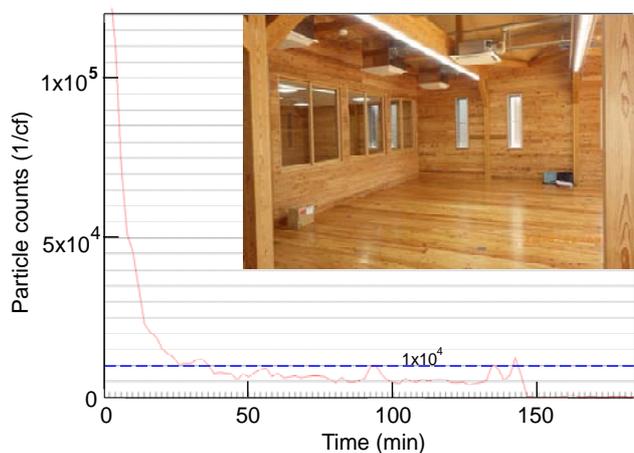


Fig. 9 Particle count as function of time in a large-sized room-type CUSP. The inset is a picture of the room before furniture is brought in.

III. CONCLUSIONS

Clean versatile environments having small footprint, low power-consumption and high cost-performance can be realized with clean unit system platforms (CUSPs) for the next generation production system as well as for cross-disciplinary experiments. By feeding back the outlet air into the inlet of the CUSP unit, the steady-state airborne-particle-count in the system becomes independent of the ambient particle count and dependent little on the particle-arrest efficiency of the filter. We can realize the cleanliness of US FED class 1~5000 for various applications. The CUSP being a closed system having no pressure difference between inside and outside, high cleanliness can be achieved with CUSP, no matter how dusty the ambient is. Thus, CUSP can provide us with the high cleanliness, for example, in a laboratory, office or home in inexpensive manner.

Desk-top type CUSPs, Mobile CUSP, and L-CUSP in which people can stay doing processes, foldable tent-type CUSP (T-CUSP), and room-style CUSP are now available. Multiply-connected CUSP system based upon those would serve as the platform not only for nano-technologies or bio-technologies but also for the next-generation environment-friendly platform for industries and medicines, especially family/community medicine. In terms of low power-consumption and high cost-performance, CUSP in its full line-up could outperform a conventional cleanroom (“main frame”) and would be *the cleanroom for all of us*.

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First Author: Akira Ishibashi received the B.Sc. and M.Sc. degrees in physics in 1981 and 1983, respectively, and the Ph.D. degree in 1990, all from the University of Tokyo, Tokyo, Japan. During 1982–1983, he held a Research Assistantship at Lawrence Berkeley National Laboratory, Berkeley, CA, USA. In 1983, he joined the Research Center of Sony Corporation, Yokohama, Japan. He was a Visiting Faculty at Loomis Laboratory, University of Illinois at Urbana-Champaign, during 1990-1991. He achieved world-first RT CW operation of Blue Laser Diode based on ZnMgSSe in Sony. He was a Visiting Professor at Tohoku University, Sendai, Japan in 1998. In 2003 he joined RIES, Hokkaido University and is now leading Nanostructure Physics Lab. Since 2006, he has been the CTO of C'sTEC Corporation. His main targets are high-efficiency solar cells and versatile clean systems, not only to process those devices but also to help people live in a high standard. He is a member of the Physical Society of Japan and the Japan Applied Physics Society.



Second Author: Masahiro Yasutake is Professor and Chair of the Department of General Medicine & Health Science at Nippon Medical School. He is a cardiovascular specialist and now exploiting CUSP for health care and medicine. His current project is to assess sleep quality by Kinetosomnogram (KSG) that is recordable only in an ultra-clean condition with CUSP.



Third Author: Nobutoshi Noguchi is chairman and executive director of Ishibashi Architects and Associates. He has been a first-class registered architect since 1973. For 1986–2006, he was a committee member for examination of the class-2 architects and the wooden building architects. He was also a board member of Architect Examination in Saga prefecture for 2003–2008. He has been a Certified Construction Manager of Japan (CCMJ) since 2005.



Fourth Author: Tsukio Etoh is the president of Kindai Setsubi-Sekkei Jimusho (KSSJ). He has been a registered engineer of building services since 1975, and he is a member of the Society of Heating, Air-conditioning and Sanitary Engineering of Japan. He started KSSJ in 1977, and has been engaged in planning, investigation, designing, and management of engineering and building services



Fifth Author: Junji Matsuda is the President of Hiei Kensetsu Corporation. He has been a first-class registered architect since 1991. He started Hiei Kensetsu in 1995, and has been engaged in planning, designing, construction, management of dwelling houses and condominiums. He is also an expert of reforms, extension, and reconstruction of houses and condominiums.



Sixth Author: Koichi Nakaya graduated from sapporo dental vocational school in 2000. Dental Hospital trainee, Hokkaido University in 2000–2001. He worked at the dental laboratory in 2001–2011. He has been interested in clean system and its possible application to dental processes, and he had developed Dental Safety System (DSS) that can protect dental technician from the risk of pneumoconiosis when he was a member of C'sTEC Corporation in 2011–2012. He is a distinguished dental technician and is now with Dental VAMOS.



Seventh Author: Takashi Osawa graduated from Tokyo Medical and Dental University in 1972, and joined Dental Hospital, Hokkaido University in 1975. In 1998, he became the head of Dental Laboratory, Dental Hospital, and in 2003 the head of dental technicians, Hokkaido University Hospital. He retired from Hokkaido University in 2014, and started "Avery laboratory", a dental laboratory. He is a member of The Nippon Academy Dental Technology. He also is a lecturer at Dental School, Yoshida Gakuen.



Eighth Author: Yoshiaki Sato graduated from Faculty of Dentistry, Nagasaki Univ., and received Ph. D. degree from School of Dentistry, Hokkaido University in 1993. He is an associate professor majoring in orthodontics in Hokkaido University Hospital. He has been engaged in clinical research of orthodontics, aesthetic appreciation, and biomechanics concerning dental occlusion and articulation.



Ninth Author: Noboru Ohata D.D.S. graduated from School of Dentistry Hokkaido University in 1973, received Ph.D. degree from Hokkaido University in 1981, and Professor Emerita from Hokkaido University in 2012. He educated students as an assistant professor during 1973-1977, an instructor during 1977-1982, an associate professor during 1982-1997, a professor during 1997-2012, all in Department of Fixed Prosthodontics, School of Dentistry Hokkaido University.



Tenth Author: Md. D. Rahaman is currently working as an Associate Professor in the Department of Physics at University of Dhaka, Bangladesh. He has received the B.Sc. and M.Sc. degrees in Physics from the University of Dhaka, Bangladesh in 1996 and 1997, respectively and Ph.D. degree from the Hokkaido University, Japan in 2008. His research interest is on the experimental condensed matter physics and materials science. He is working on low-loss magneto-dielectric materials with matching permeability and permittivity for miniaturization and efficiency improvement of antenna and novel multiferroic magnetolectric composite materials.



Eleventh Author: Javier Alda received his Lic. in Science in 1985 from University of Zaragoza (Spain) and his PhD degree in Physics from University Complutense of Madrid (Spain) in 1988. He joined the Optics Department of the University Complutense of Madrid in 1985 where he is now full professor. He has coauthored more than 120 paper on several topics in Applied Optics, ranging from Laser Beam Propagation to Nanophotonics. Since 1998 his main research interest is focus on the use of optical antennas and resonant structures for a variety of applications in the infrared and the visible range. He is a member of the Optical Society of America and a Fellow member of the International Society for Optics and Photonics, SPIE.



Twelfth Author: Yoshihisa Ohashi graduated from University of California, Irvine, USA. He worked at Thomson Japan 1983–1984, GE Japan 1984–94 for electronics. From 1994 through 2009, he was a member of IDA, Ireland, and devoted himself for development of the relationship between Japan and Ireland. In 2006, he started Hokkaido University Venture Company, C'sTEC Corporation with Prof. A. Ishibashi, and Y. Ohashi has been the CEO of C'sTEC since then.

